## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | LEE ET AL. | Examiner | Art Unit | Yonas Bayou | 2134 | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0023425	09-2001	Oberman et al.	708/620
	В	US-			
	С	US-			
	D	US-			
	E	US-		:	
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## FOREIGN PATENT DOCUMENTS

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